

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10618338	JIAO ET AL.
	Examiner	Art Unit
	XIAOZHEN XIE	1646

SEARCHED

Class	Subclass	Date	Examiner
none			

SEARCH NOTES

Search Notes	Date	Examiner
EAST: USPAT, US-PGPUB, EPO, JPO, DERWENT (see search history)	1/30/2009	XZ
STN: Medline, Embase, Biosis, CAplus, PCTfull (see search history)	1/30/2009	XZ
Inventor names: searched in PALM	1/30/2009	XZ
SEQ ID NOs: 1, 3, 11-16 searched by STIC (see SCORE)	1/23/2009	XZ

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

--	--